

N- AND P-Channel Enhancement Mode Power MOSFET

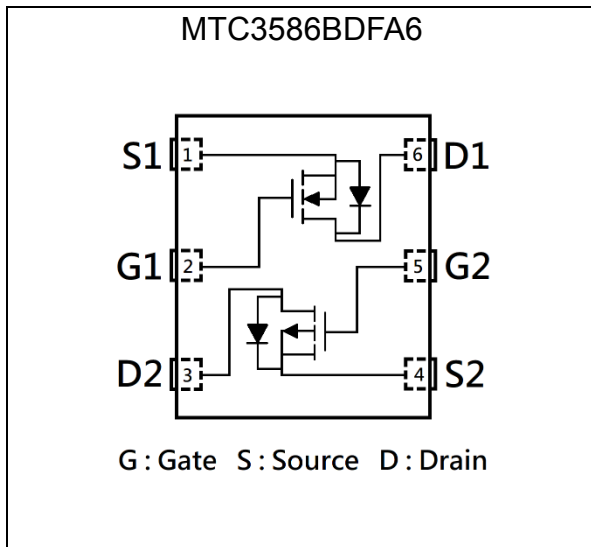
MTC3586B DFA6

Features

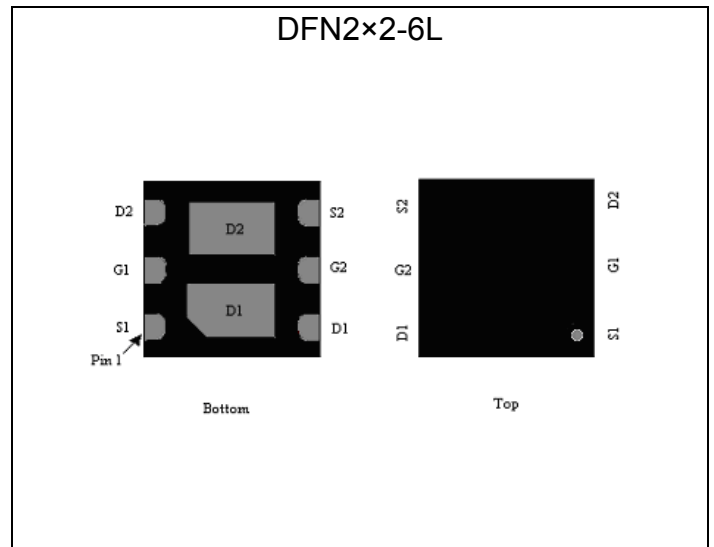
- Low On Resistance
- Low Gate Charge
- Fast Switching Characteristic

	N-CH	P-CH
BV_{DSS}	20V	-20V
$I_D@V_{GS}=(-)4.5V, T_C=25^\circ C$	8A	-5.6A
$I_D@V_{GS}=(-)4.5V, T_A=25^\circ C$	4.6A	-3.2A
$R_{DS(ON)typ.}@V_{GS}=(-)4.5V$	24mΩ	60mΩ
$R_{DS(ON)typ.}@V_{GS}=(-)2.5V$	28mΩ	80mΩ
$R_{DS(ON)typ.}@V_{GS}=(-)1.5V$	55mΩ	160mΩ

Equivalent Circuit

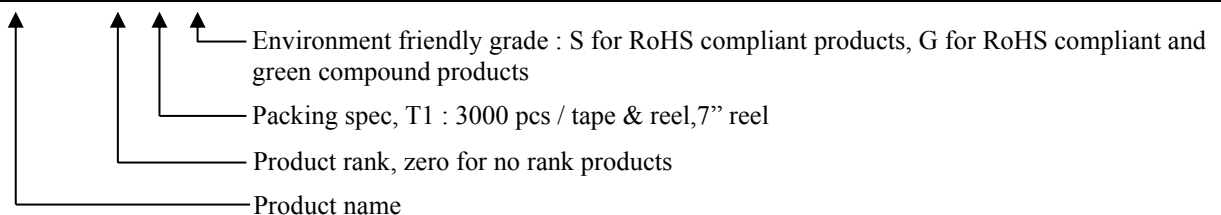


Outline



Ordering Information

Device	Package	Shipping
MTC3586B DFA6-0-T1-G	DFN2x2-6L (RoHS compliant & Halogen-free package)	3000 pcs / Tape & Reel



**Absolute Maximum Ratings (TA=25°C)**

Parameter	Symbol	Limits		Unit	
		N-CH	P-CH		
Drain-Source Voltage	V _{DS}	20	-20	V	
Gate-Source Voltage	V _{GS}	±8	±8		
Continuous Drain Current @ V _{GS} =(-)4.5V, T _C =25°C	*a	I _D	8	-5.6	A
Continuous Drain Current @ V _{GS} =(-)4.5V, T _C =100°C	*a		5.1	-3.5	
Continuous Drain Current @ V _{GS} =(-)4.5V, T _A =25°C	*b		4.6	-3.2	
Continuous Drain Current @ V _{GS} =(-)4.5V, T _A =70°C	*b		3.7	-2.6	
Pulsed Drain Current	*c	I _{DM}	32	-22	
Continuous Body Diode Forward Current @ T _C =25°C	*a	I _S	3.3	-3.3	
Avalanche Current @ L=0.1mH		I _{AS}	8	-8	
Avalanche Energy @ L=0.5mH		E _{AS}	6	6	mJ
Total Power Dissipation	T _C =25°C	P _D	4		W
	T _C =100°C		1.6		
	T _A =25°C		1.3		
	T _A =70°C		0.8		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55~+150		°C

Thermal Data

Parameter	Symbol	Steady State	Unit
Thermal Resistance, Junction-to-case	R _{θJC}	31	°C/W
Thermal Resistance, Junction-to-ambient	*b R _{θJA}	95	

Note:

- *a. The power dissipation P_D is based on T_{J(MAX)}=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- *b. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2 oz. copper, in a still air environment with T_A=25°C. The power dissipation P_D is based on R_{θJA} and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- *c. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150°C. Ratings are based on low frequency and low duty cycles to keep initial T_J=25°C.



N-Channel Electrical Characteristics (T_A=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	20	-	-	V	V _{GS} =0V, I _D =250μA
V _{GS(th)}	0.3	-	1		V _{DS} =V _{GS} , I _D =250μA
G _{FS}	-	7	-	S	V _{DS} =5V, I _D =3A
I _{GSS}	-	-	±100	nA	V _{GS} =±8V, V _{DS} =0V
I _{DSS}	-	-	1	μA	V _{DS} =16V, V _{GS} =0V
R _{DS(ON)}	-	24	34	mΩ	V _{GS} =4.5V, I _D =3A
	-	28	42		V _{GS} =2.5V, I _D =1A
	-	55	140		V _{GS} =1.5V, I _D =0.5A
Dynamic					
C _{iss}	-	450	-	pF	V _{DS} =10V, V _{GS} =0V, f=1MHz
C _{oss}	-	65	-		
C _{rss}	-	60	-		
R _g	-	1	-	Ω	f=1MHz
Q _g *1,2	-	6.7	-	nC	V _{DS} =10V, I _D =3A, V _{GS} =4.5V
Q _{gs} *1,2	-	0.7	-		
Q _{gd} *1,2	-	1.5	-		
t _{d(ON)} *1,2	-	4	-	ns	V _{DS} =10V, I _D =1A, V _{GS} =5V, R _{GS} =3.3Ω
t _r *1,2	-	15.5	-		
t _{d(OFF)} *1,2	-	28	-		
t _f *1,2	-	5	-		
Source-Drain Diode					
V _{SD} *1	-	0.85	1.2	V	I _S =3A, V _{GS} =0V
t _{rr}	-	5.5	-	ns	I _F =3A, dI _F /dt=100A/μs
Q _{rr}	-	2	-	nC	

Note:

- *1. Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%
- *2. Independent of operating temperature



P-Channel Electrical Characteristics (T_A=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	-20	-	-	V	V _{GS} =0V, I _D =-250μA
V _{GS(th)}	-0.3	-	-1		V _{DS} =V _{GS} , I _D =-250μA
G _{FS}	-	6	-	S	V _{DS} =-5V, I _D =-2A
I _{GSS}	-	-	±100	nA	V _{GS} =±8V, V _{DS} =0V
I _{DSS}	-	-	-1	μA	V _{DS} =-16V, V _{GS} =0V
R _{DS(ON)}	-	60	84	mΩ	V _{GS} =-4.5V, I _D =-2.5A
	-	80	120		V _{GS} =-2.5V, I _D =-2A
	-	160	400		V _{GS} =-1.5V, I _D =-0.5A
Dynamic					
C _{iss}	-	660	-	pF	V _{DS} =-10V, V _{GS} =0V, f=1MHz
C _{oss}	-	60	-		
C _{rss}	-	58	-		
R _g	-	13.7	-	Ω	f=1MHz
Q _g *1, 2	-	7.8	-	nC	V _{DS} =-10V, I _D =-2A, V _{GS} =-4.5V
Q _{gs} *1, 2	-	1	-		
Q _{gd} *1, 2	-	1.6	-		
t _{d(ON)} *1, 2	-	5	-	ns	V _{DS} =-10V, I _D =-1A, V _{GS} =-5V, R _{GS} =3.3Ω
t _r *1, 2	-	17	-		
t _{d(OFF)} *1, 2	-	48	-		
t _f *1, 2	-	6	-		
Source-Drain Diode					
V _{SD} *1	-	-0.85	-1.2	V	I _S =-2A, V _{GS} =0V
t _{rr}	-	6.2	-	ns	I _F =-2A, dI _F /dt=100A/μs
Q _{rr}	-	2.3	-	nC	

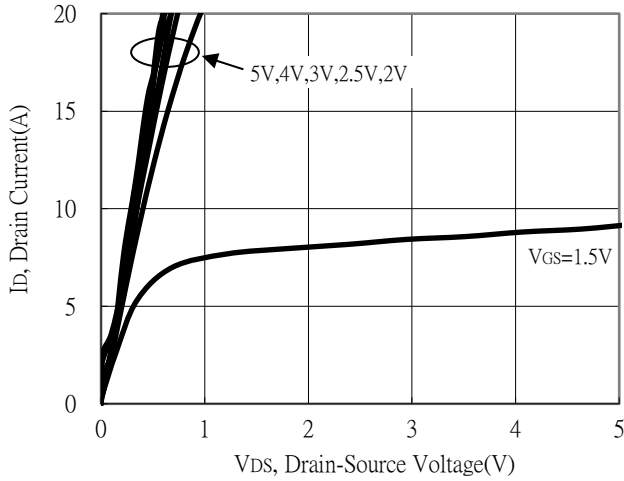
Note:

*1. Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

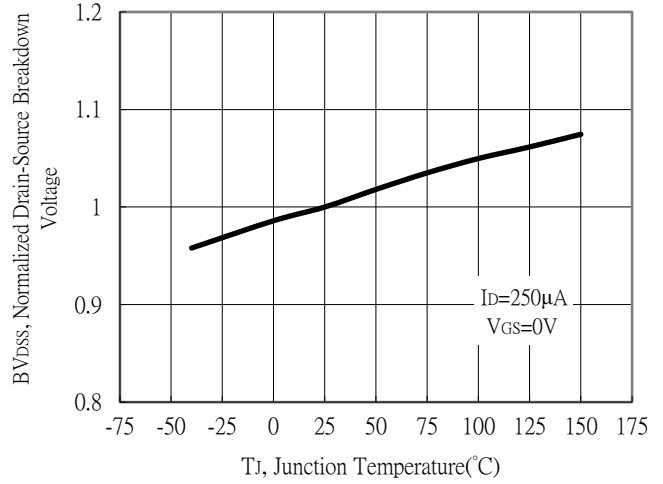
*2. Independent of operating temperature

Typical Characteristics : Q1(N-channel)

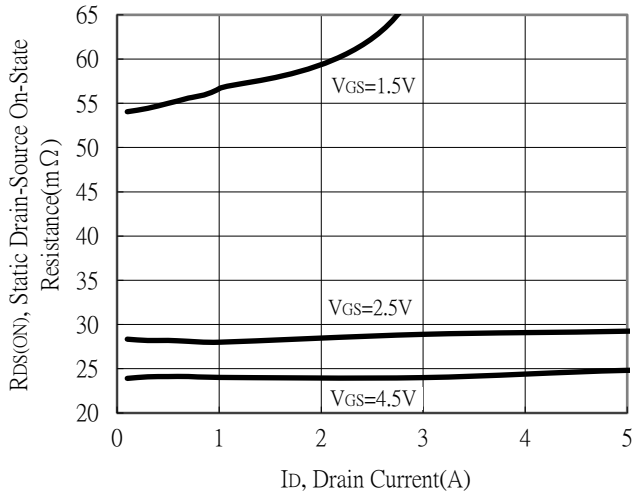
Typical Output Characteristics



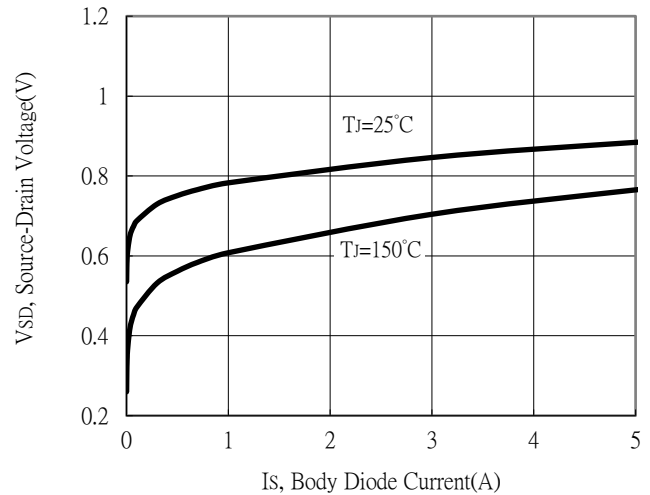
Breakdown Voltage vs Ambient Temperature



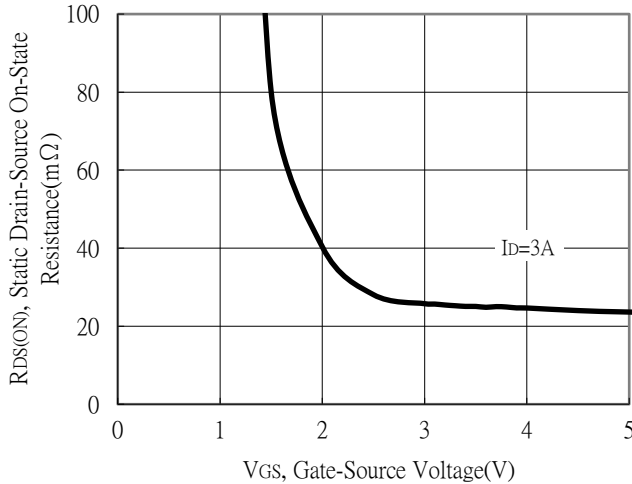
Static Drain-Source On-State resistance vs Drain Current



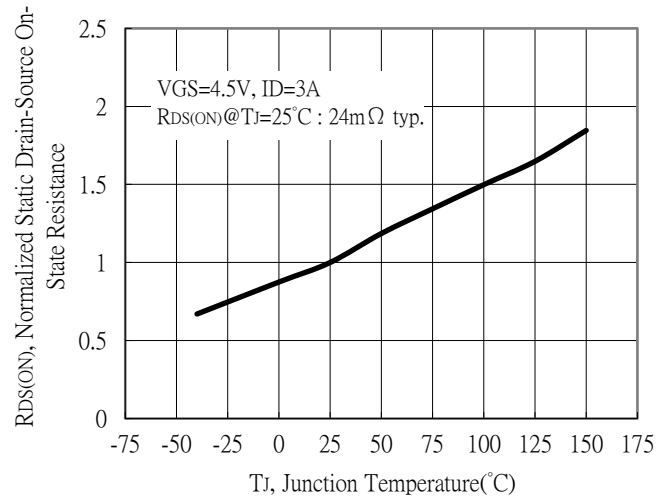
Body Diode Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

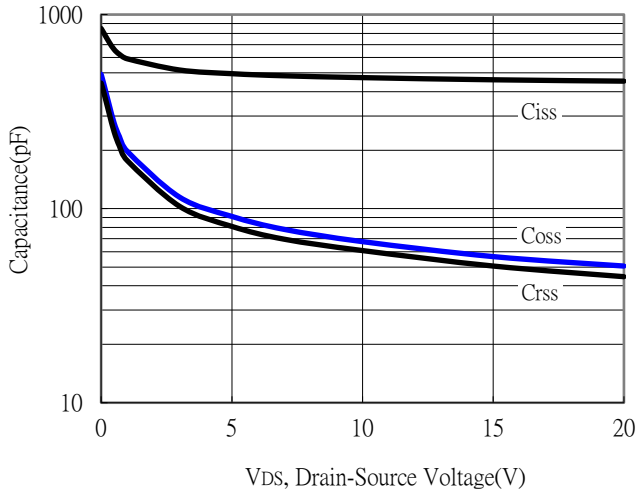


Drain-Source On-State Resistance vs Junction Temperature

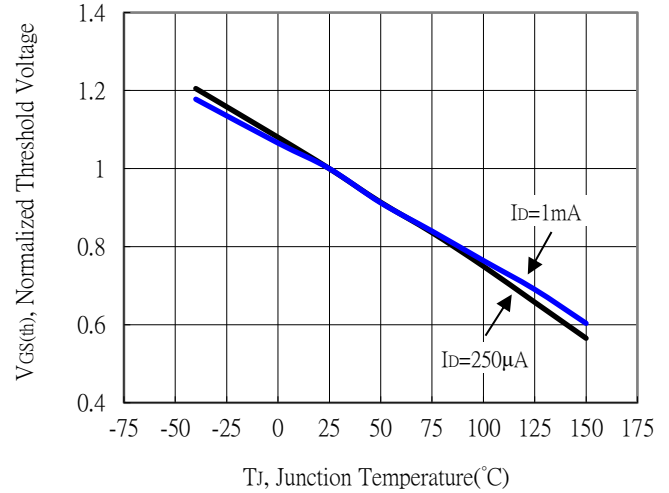


Typical Characteristics (Cont.) : Q1(N-channel)

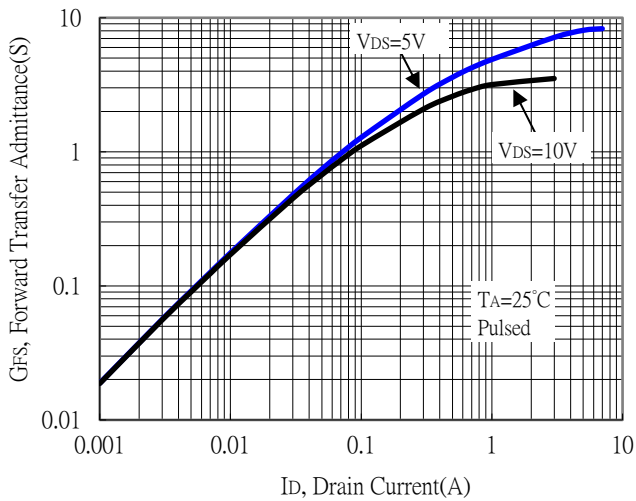
Capacitance vs Drain-to-Source Voltage



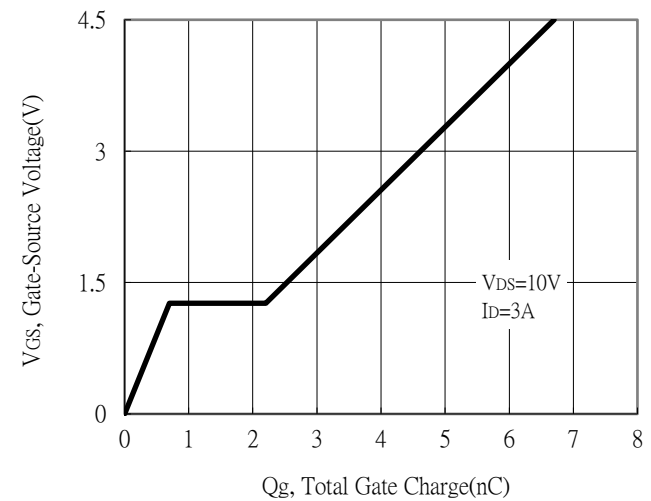
Threshold Voltage vs Junction Temperature



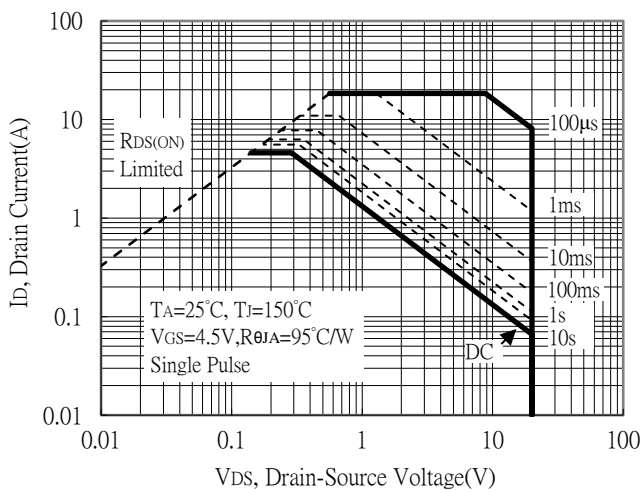
Forward Transfer Admittance vs Drain Current



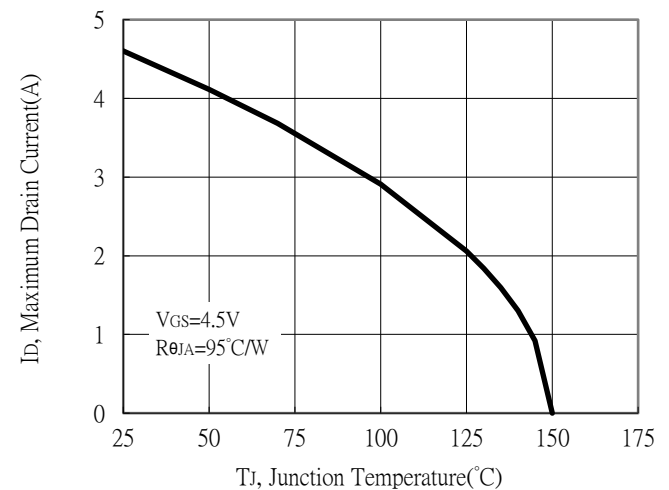
Gate Charge Characteristics



Maximum Safe Operating Area



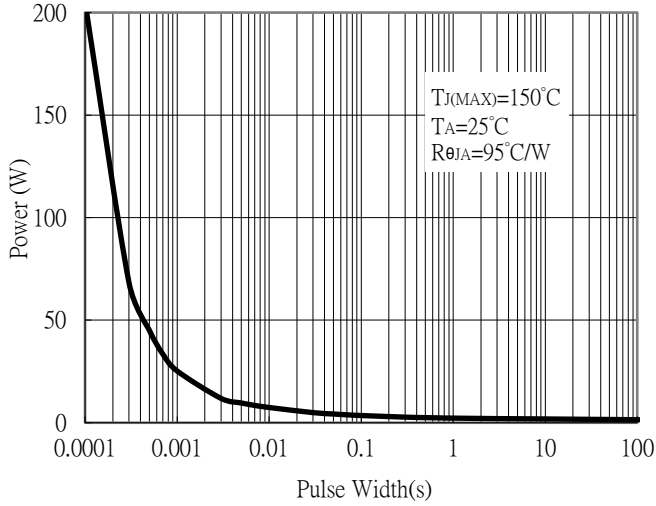
Maximum Drain Current vs Junction Temperature



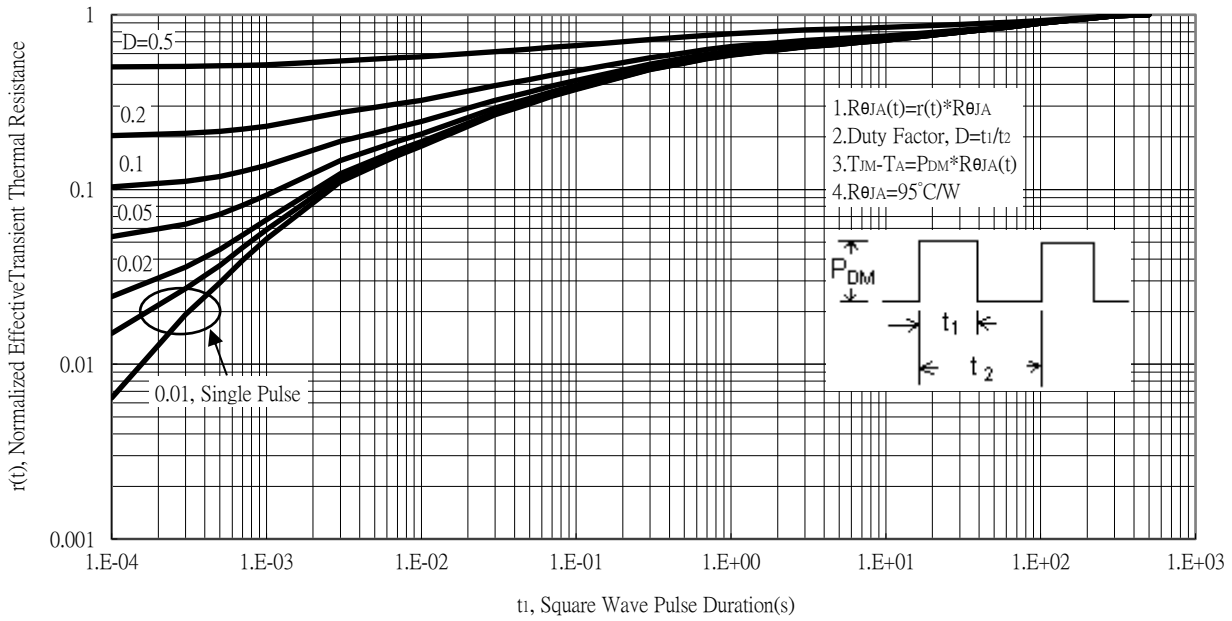


Typical Characteristics (Cont.) : Q1(N-channel)

Single Pulse Power Rating, Junction to Ambient

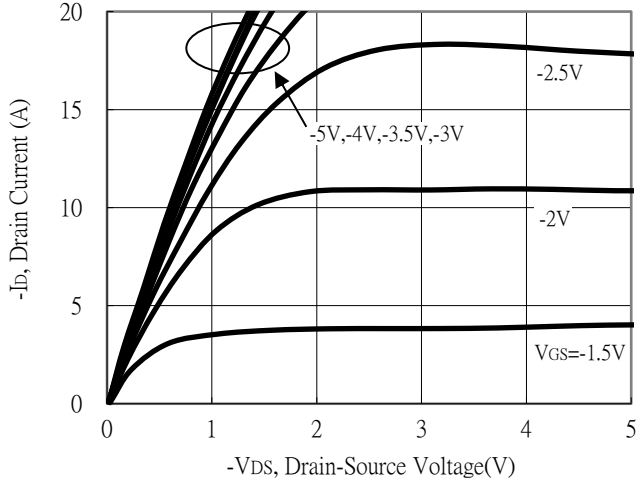


Transient Thermal Response Curves

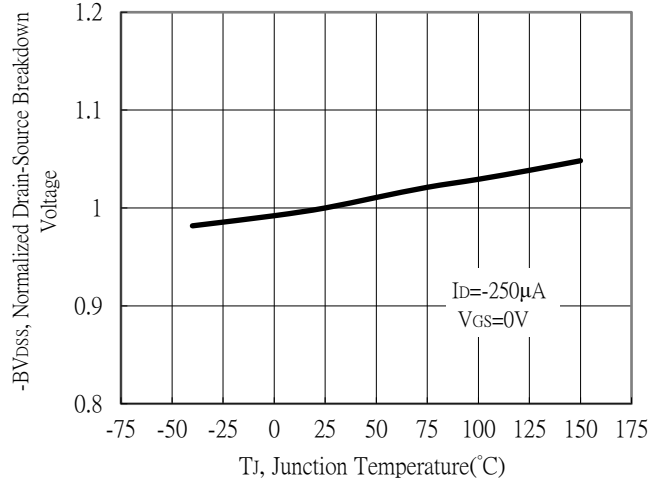


Typical Characteristics : Q2(P-channel)

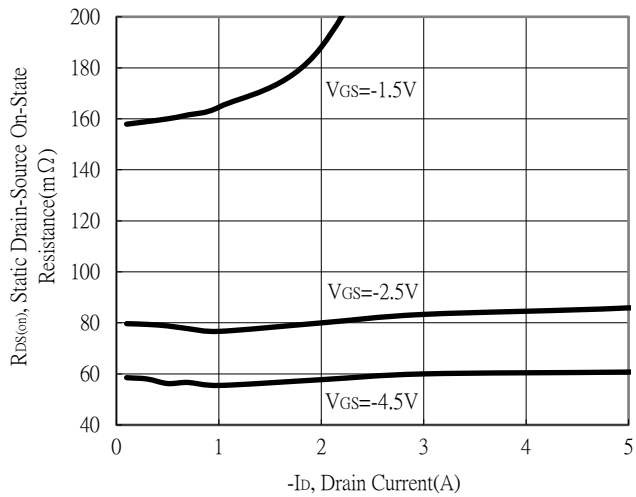
Typical Output Characteristics



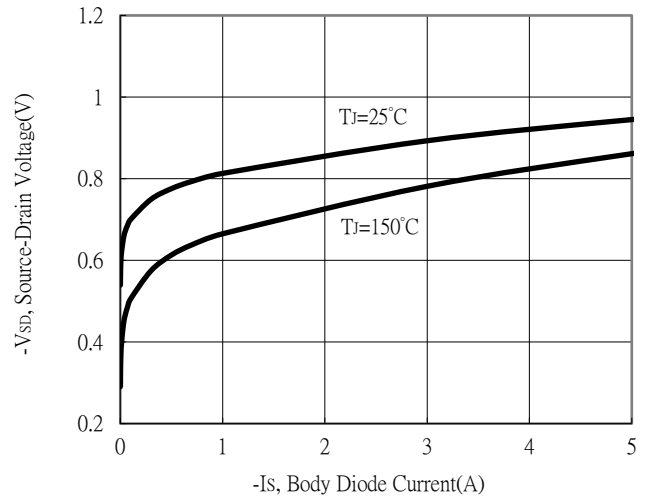
Breakdown Voltage vs Ambient Temperature



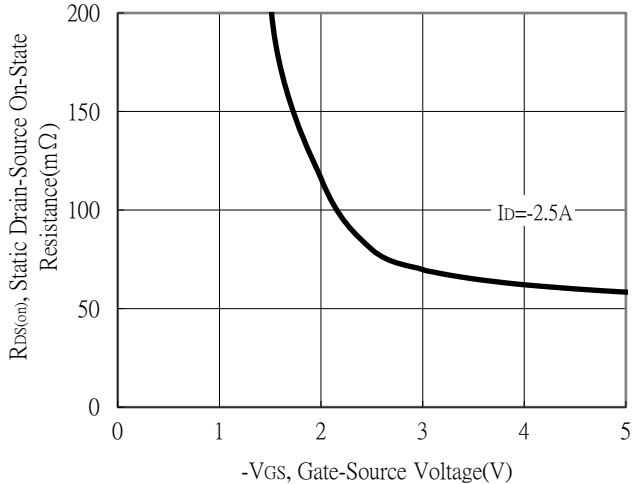
Static Drain-Source On-State resistance vs Drain Current



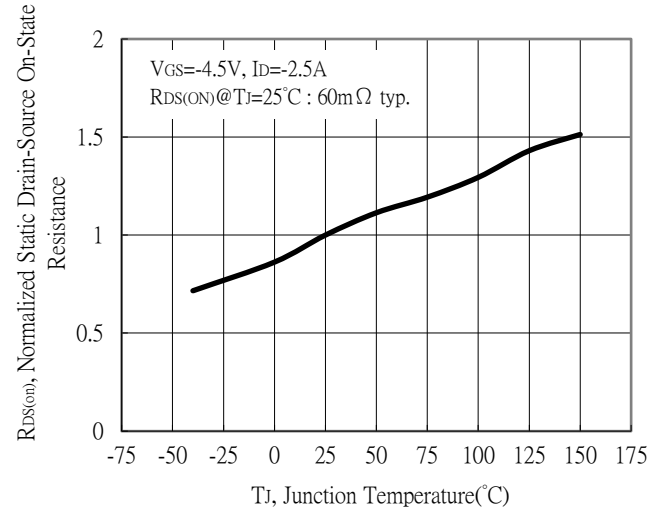
Body Diode Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

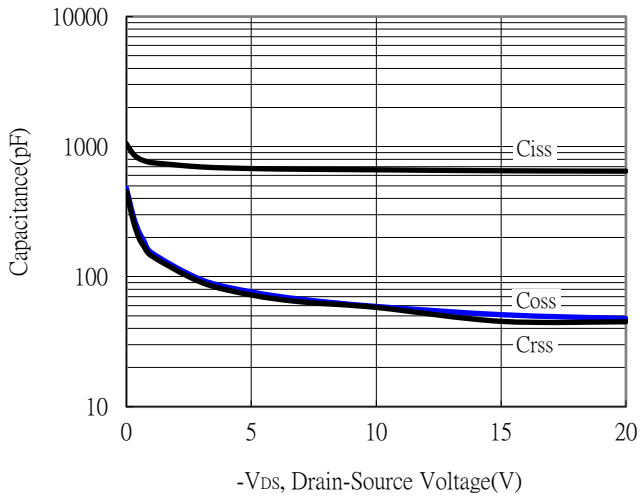


Drain-Source On-State Resistance vs Junction Temperature

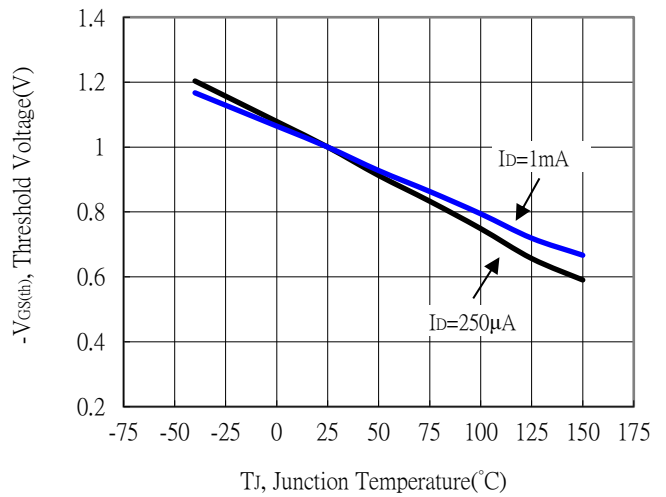


Typical Characteristics (Cont.) : Q2(P-channel)

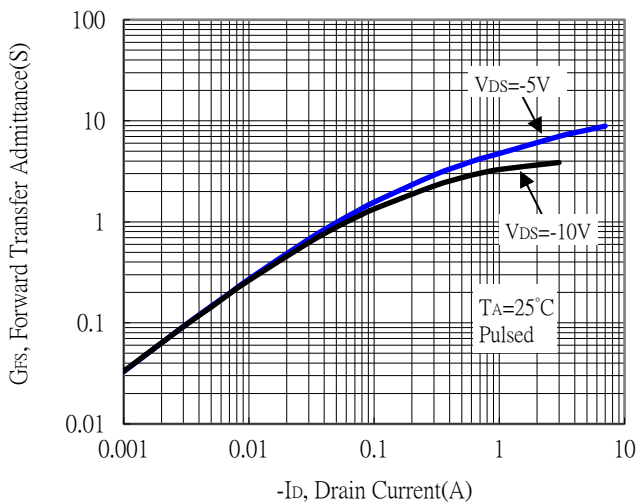
Capacitance vs Drain-to-Source Voltage



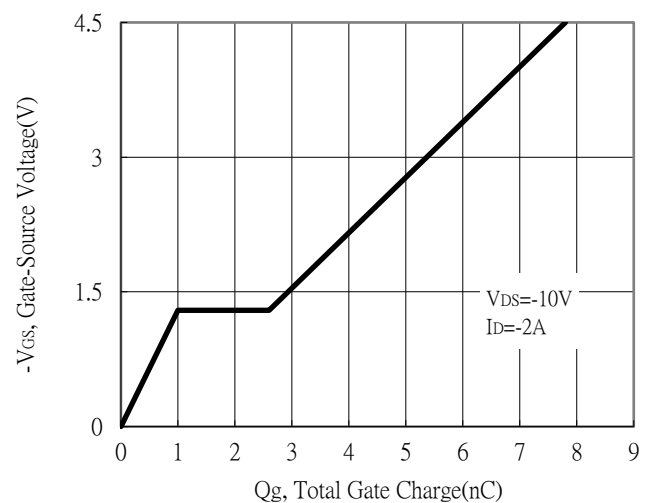
Threshold Voltage vs Junction Temperature



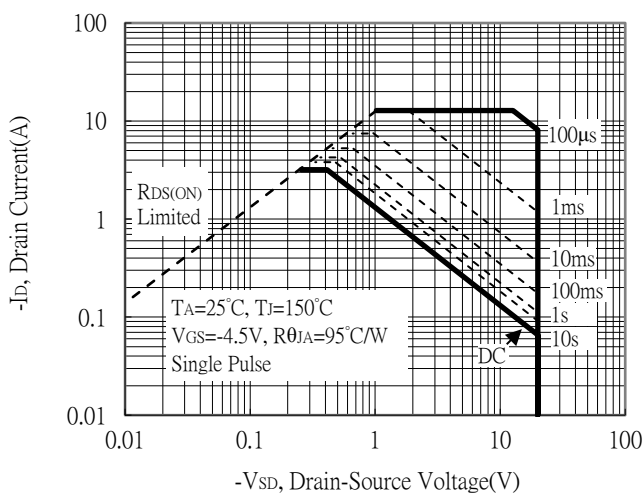
Forward Transfer Admittance vs Drain Current



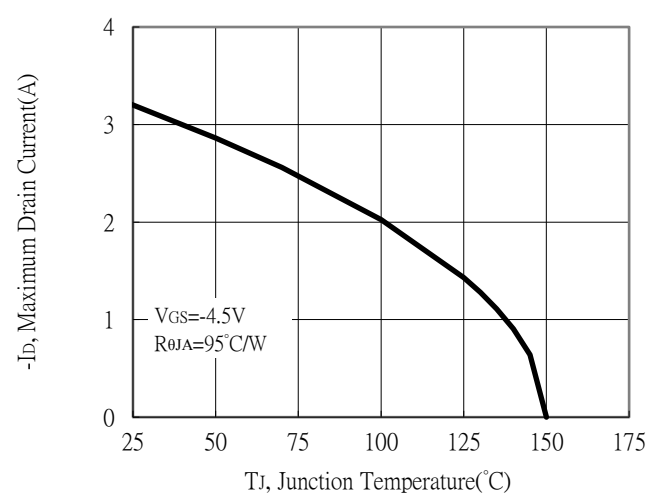
Gate Charge Characteristics



Maximum Safe Operating Area

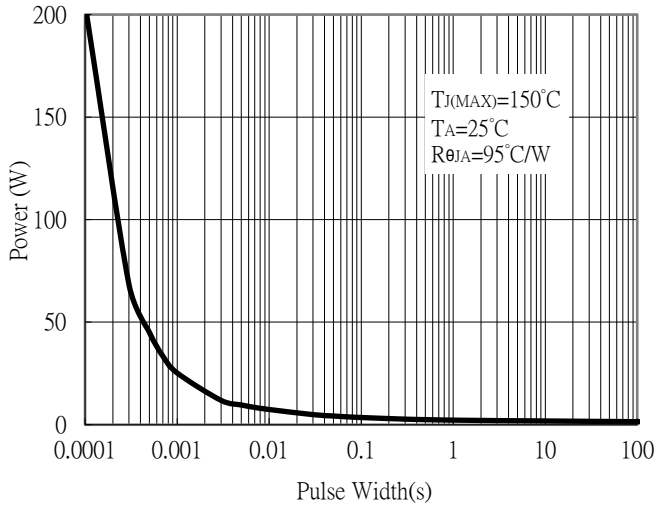


Maximum Drain Current vs Junction Temperature

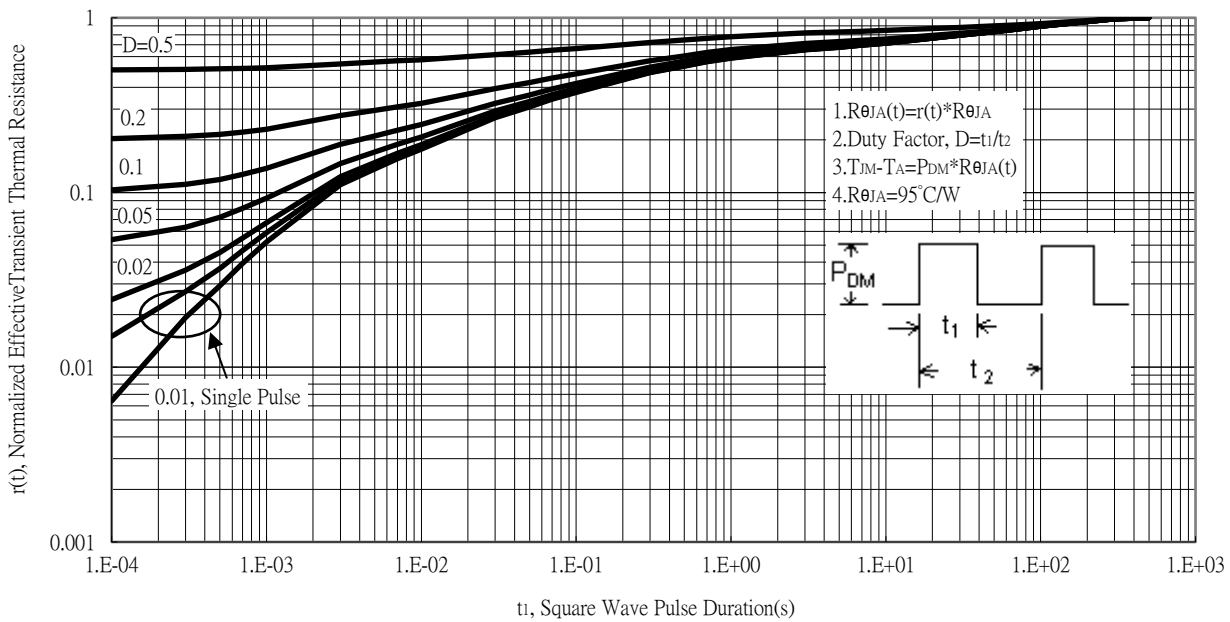


Typical Characteristics (Cont.) : Q2(P-channel)

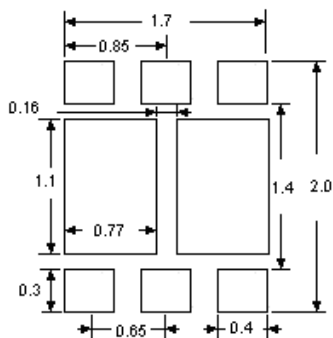
Single Pulse Power Rating, Junction to Ambient



Transient Thermal Response Curves

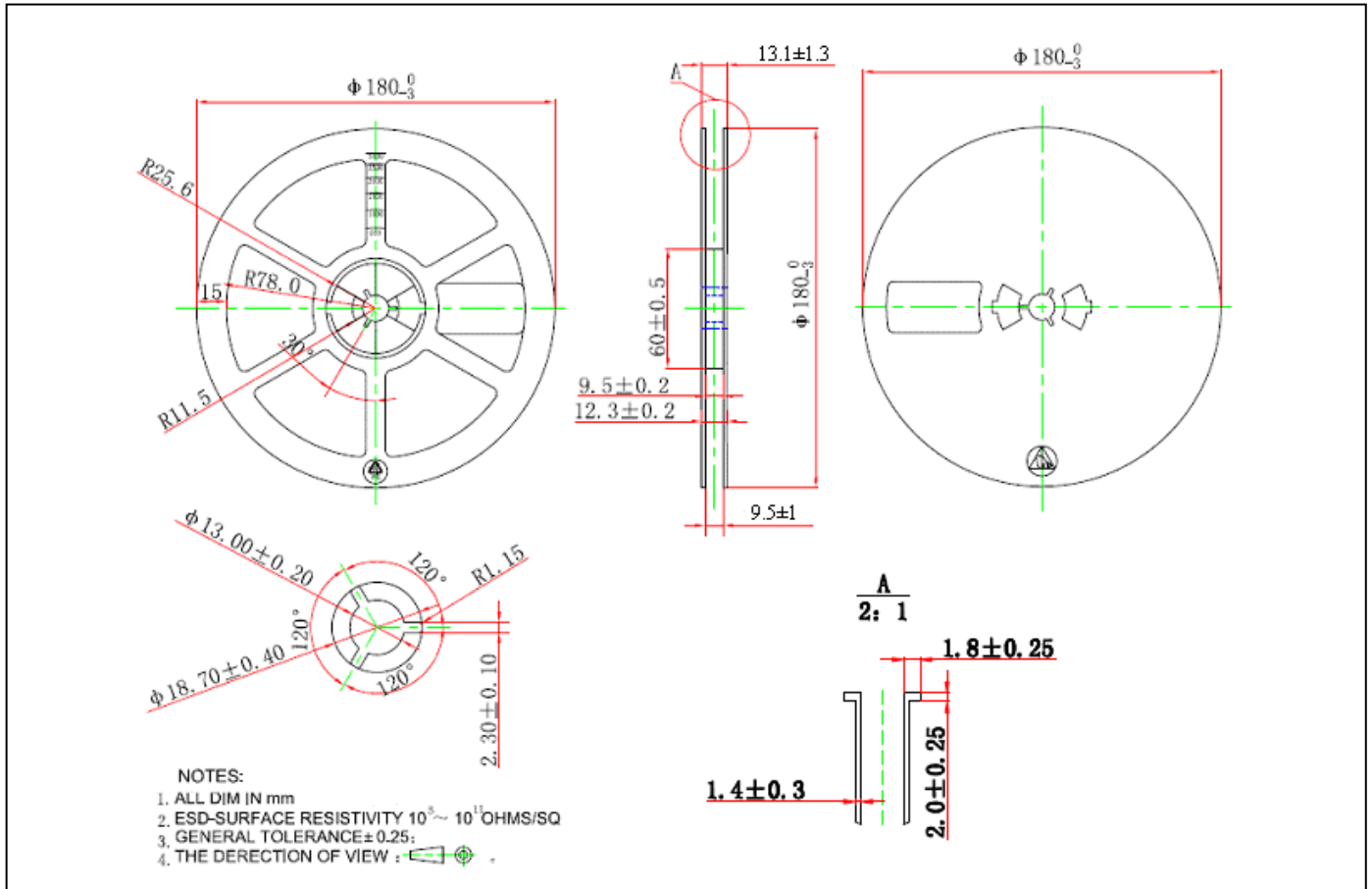


Recommended Soldering Footprint

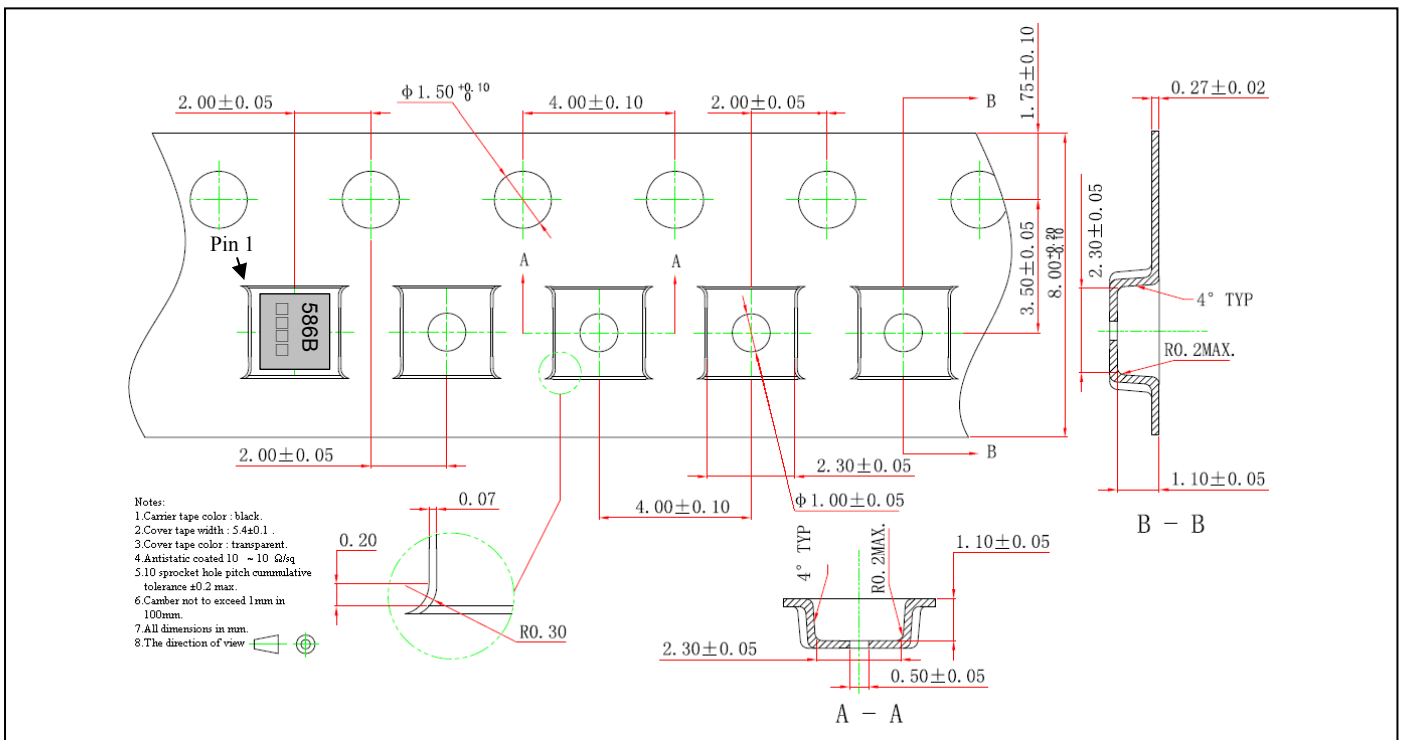


Unit : mm

Reel Dimension



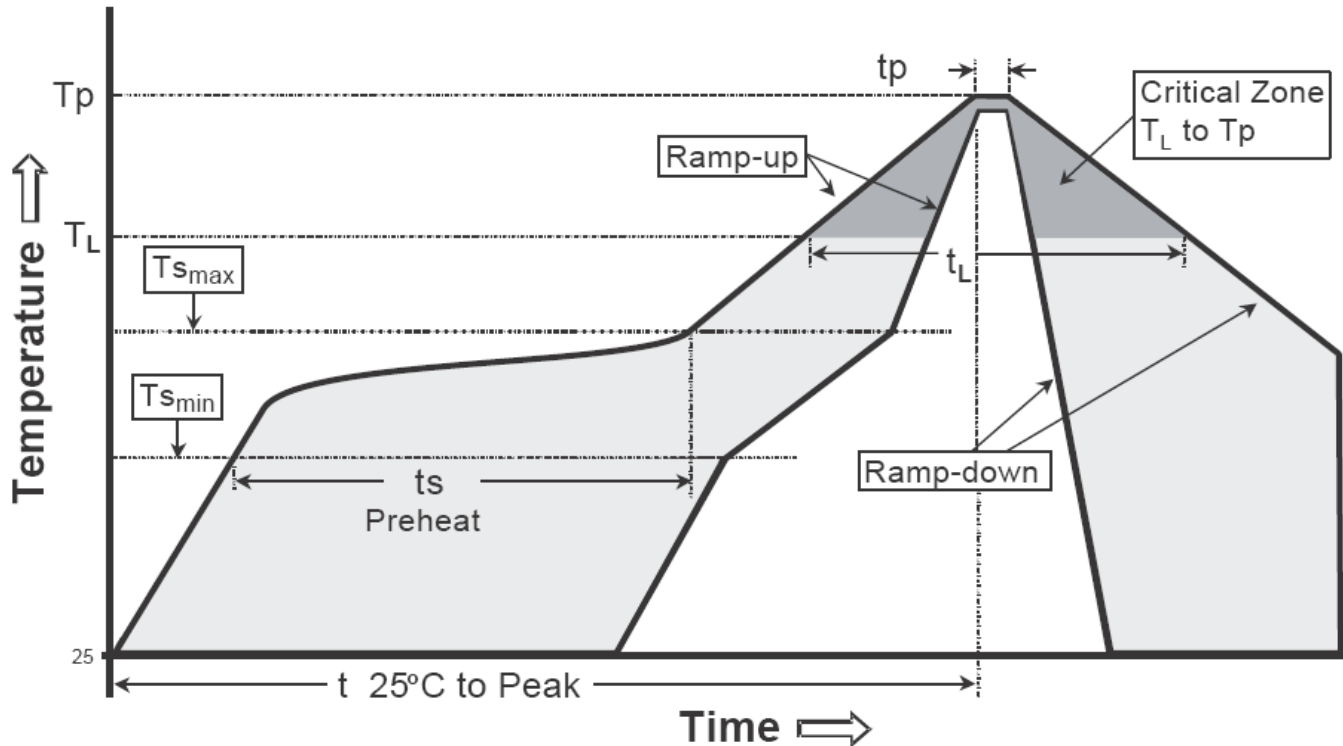
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

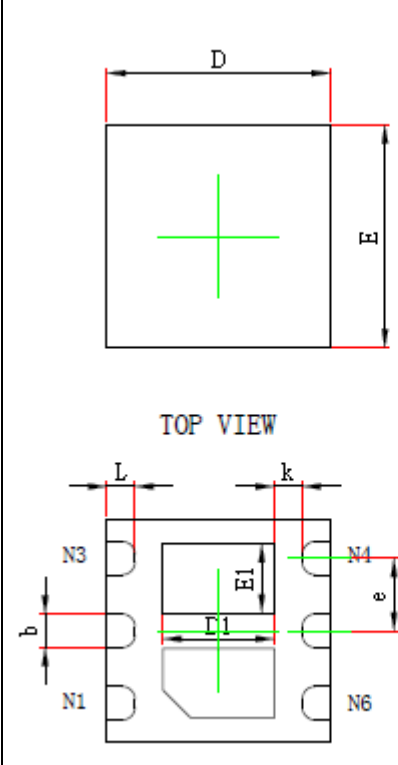
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T _{s min})	100°C	150°C
-Temperature Max(T _{s max})	150°C	200°C
-Time(t _{s min} to t _{s max})	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T _L)	183°C	217°C
- Time (t _L)	60-150 seconds	60-150 seconds
Peak Temperature(T _P)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

DFN2x2-6L Dimension

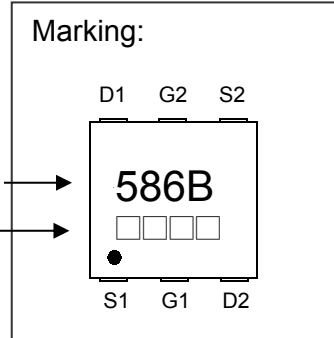


TOP VIEW

SIDE VIEW

6-Lead DFN2x2-6L Plastic Surface Mounted Package
CYStek Package Code: DFA6

Marking:



Device Code →

Date Code →

Style:

- Pin 1. Source1 (S1)
- Pin 2. Gate 1 (G1)
- Pin 3. Drain2 (D2)
- Pin 4. Source2 (S2)
- Pin 5. Gate2 (G2)
- Pin 6. Drain1 (D1)

Date Code(counting from left to right) :

1st code: year code, the last digit of Christian year

2nd code : month code, Jan→A, Feb→B, Mar→C, Apr→D, May→E, Jun→F, Jul→G, Aug→H, Sep→J, Oct→K, Nov→L, Dec→M

3rd and 4th codes : production serial number, 01~99

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.700	0.800	0.028	0.031	E1	0.520	0.720	0.020	0.028
A1	0.000	0.050	0.000	0.002	k	0.200	-	0.008	-
A3	0.203	REF	0.008	REF	b	0.250	0.350	0.010	0.014
D	1.900	2.100	0.075	0.083	e	0.650	TYP	0.026	TYP
E	1.900	2.100	0.075	0.083	L	0.200	0.300	0.008	0.012
D1	0.900	1.100	0.035	0.043					

- Notes :**
- Controlling dimension : millimeters.
 - Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 - If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material :

- Lead :Pure tin plated.
- Mold Compound : Epoxy resin family, flammability solid burning class:UL94V-0.

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